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# Specifying Holdover for OCP-TAP Oscillator Classes in Data Centers

Gary Giust, PhD

OCP-TAP Oscillator Workstream, Lead  
Sr. Mgr Technical Marketing, SiTime

Nazar Tshchynskyy

Sr. Mgr Customer Engineering, SiTime

Jeff Gao

Sr. Dir Marketing, SiTime

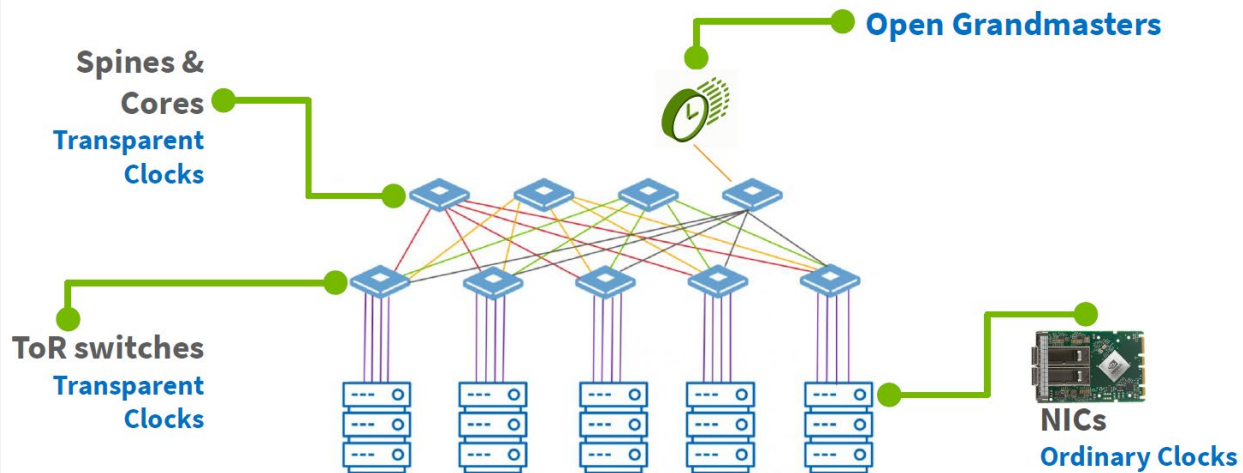




# Agenda

1. Motivation
2. Test parameters – use case dependent
3. Test method – use case independent
4. Call to action

# OCP-TAP Simplifying Oscillator Selection



## Problem

- Difficult to understand holdover performance from oscillator datasheet
- Difficult to select oscillator for a use case

## Goal

- Enable transparent, apples-to-apples comparison of oscillator holdover

## Proposed Solution

- Specify max time error at holdover time,  $\tau_h$
- Specify a holdover test methodology

# OCP-TAP Specifies Test Parameters

## Use Case Dependent



TIME  
APPLIANCES

- Holdover time,  $\tau_h$
- Thermal profile – target starting temperature, ramp rate, soak time
- Operating ambient-temperature range
- Ambient temperature to measure aging
- Ambient temperature to measure frequency versus time trend
- Acceptable probability of error,  $P_E$ , required by system
- Training time before entering holdover,  $\tau_{Training}$
- Sample-unit population, N, and distribution
  - For example: 10 random units from each of 3 lots, each with a different process and assembly
- Trial population, M, to capture random variations per unit
- Whether the system compensates for aging

# OCP-TAP Specifies Test Method

## Use Case Independent



TIME  
APPLIANCES

### Measure

- Frequency stability over the specified operating ambient temperature range
- Frequency versus time at the specified ambient temperature

### Compute

- Extract daily aging, thermal drift and wander from measured data
- Max time error  $E_{max}(\tau_h)$  up to holdover time  $\tau_h$  and derived from Gaussian distributions for
  - Aging –  $m_a(\tau_h), \sigma_a(\tau_h)$
  - Thermal drift –  $m_T(\tau_h), \sigma_T(\tau_h)$
  - Wander –  $m_w(\tau_h), \sigma_w(\tau_h)$

### Report

- $E_{max}(\tau_h)$
- Vendor-specific test conditions and restrictions needed to reproduce results



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Aging

Thermal  
Drift

Wander

# Model Contributions to Time Error



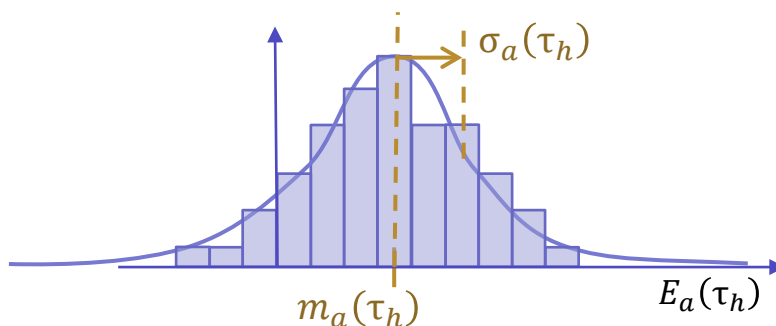
TIME  
APPLIANCES

POPULATION

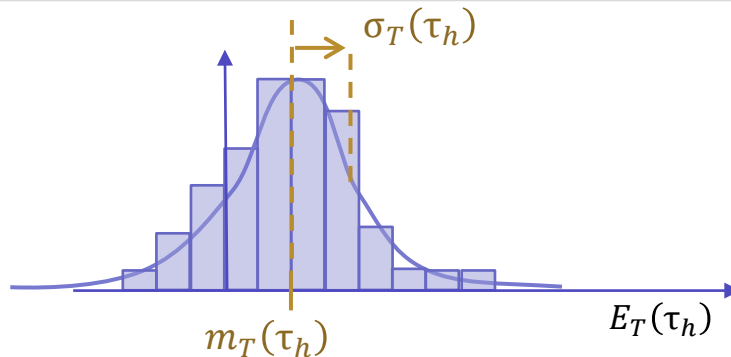
TIME ERROR HISTOGRAM

TOTAL TIME ERROR

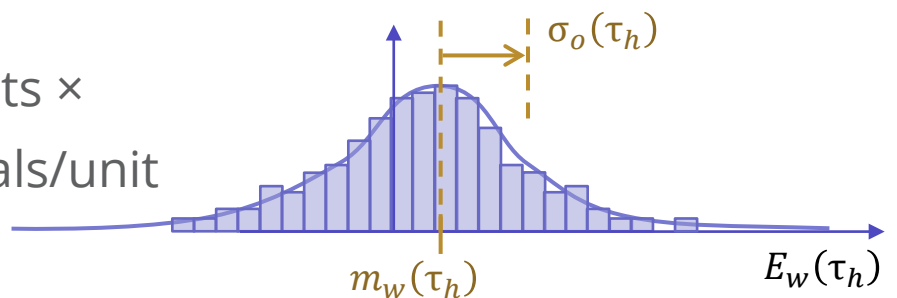
N units



N units



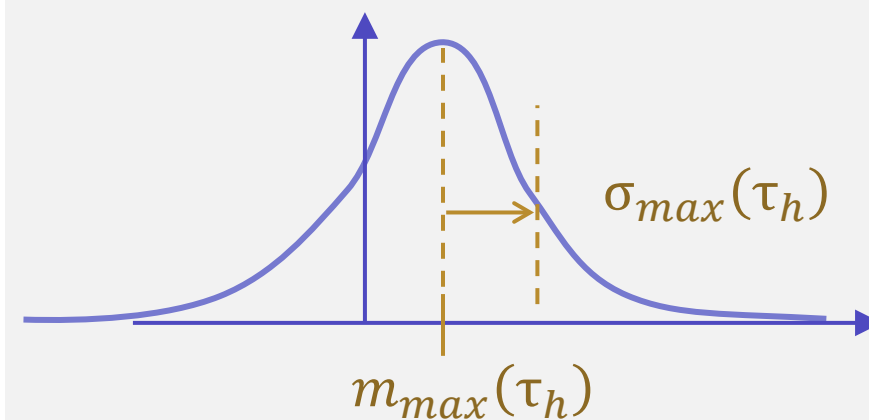
N units ×  
M trials/unit



$$m_{max}(\tau_h) = m_a(\tau_h) + m_T(\tau_h) + m_w(\tau_h)$$

$$\sigma_{max}^2(\tau_h) = \sigma_a^2(\tau_h) + \sigma_T^2(\tau_h) + \sigma_w^2(\tau_h)$$

Total Distribution of Time Error at  $\tau_h$



# Compute Max Time Error



2 Possibilities

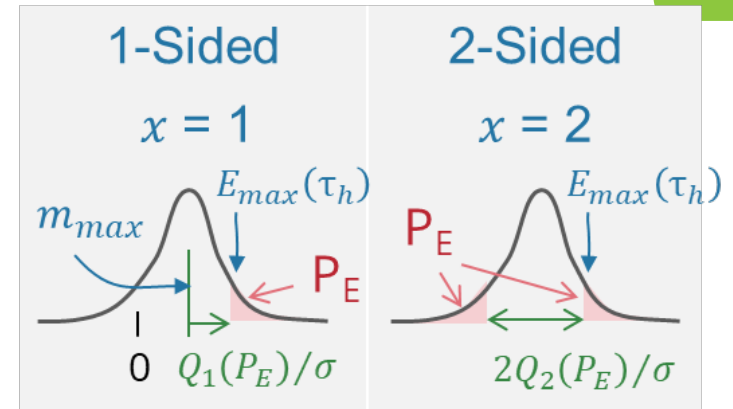
$$E_{max}(\tau_h) = m_{max}(\tau_h) + Q_x(P_E)\sigma_{max}(\tau_h)$$

$|m_{max}| \gg 0$

$m_{max} \cong 0$

TIME  
APPLIANCES

Q converts RMS to Peak for a specified error rate,  $P_E$



## Interpretation

- All units shipped will not exceed  $E_{max}(\tau_h)$  up to holdover time  $\tau_h$  with at most probability of error  $P_E$

$1-P_E$	$Q_1(P_E)/\sigma(\tau_h)$	$Q_2(P_E)/\sigma(\tau_h)$
0.682689	0.475	1.000
0.954499	1.690	2.000
0.997300	2.782	3.000
0.999002	3.091	3.291
0.999900	3.720	3.891
0.999937	3.833	4.000
0.999990	4.754	4.892
0.999994	4.865	5.000



# OCP-TAP Welcomes Your Feedback

- Participate in weekly OCP-TAP Oscillator Workstream
  - Contact Gary Giust (email in Wiki page below)
  - Nov 17, OCP-TAP Main Meeting will review Oscillator Workstream work
- View recordings of Oscillator Workstream meetings on Wiki page
  - [https://www.opencompute.org/wiki/Time Appliances Project](https://www.opencompute.org/wiki/Time_Appliances_Project)
- Subscribe to OCP-TAP mailing list
  - <https://ocp-all.groups.io/g/OCP-TAP>
- “Open Time Server” Github page
  - <https://github.com/opencomputeproject/Time-Appliance-Project/tree/master/Open-Time-Server>





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